Search Notes

Application/Control N	o. Applicant(s)/Patent und Reexamination	ler
10/666,875	MAKELA ET AL.	
Examiner	Art Unit	
PHUOC H DOAN	2687	

SEARCHED					
Class	Subclass	Date	Examiner		
455	509	07/12/05	P#D		
	518				
345	762				
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	716				
709	204				
	206				
370	401	\bigvee			

Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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